SMD Type Power Inductor

SDSL10D50F-220M

	ECN HISTORY LIST							
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN			
1.0	12/12/07	新 發 行	許智良	張榮泉	徐允珮			
備								
註								

TAI-TECH P2

SMD Type Power Inductor

SDSL10D50F-220M

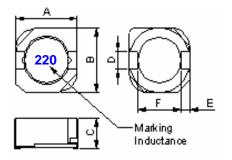
1. Features

- 1.Low profile very effective in space-conscious applications.
- 2.Low resistance and high energy storage.
- 3.100% Lead(Pb) & Halogen-Free and RoHS compliant.

2. Dimension







Series	A(mm)	B(mm)	C(mm)	D(mm)	E(mm)	F(mm)
SDSL10D50F	10.5 max.	10.3 max.	5.0 max.	3.0 ref.	1.2±0.15	7.7±0.3

Units: mm

3. Part Numbering

SDSL	10D50	F	-	220	M
Α	В	С		D	Е

- A: Series
- B: Dimension
- C: Lead free type
- D: Inductance 220=22uH
- E: Inductance Tolerance M=±20%

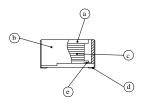
4. Specification

TAI-TECH	Inductance	Test Frequency	DCR	I sat	I rms
Part Number	(uH)	(Hz)	(mΩ) max.	(A) max.	(A) typ.
SDSL10D50F-220M	22±20%	0.1V/100K	61.0	2.90	2.95

5. Schematic Diagram



6. Materials



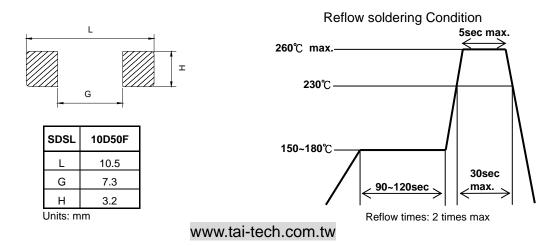
l	No.	Description	Specification		
	a.	Core	Ferrite DR Core		
	b.	Core	Ferrite RI Core		
	C.	Wire	Enamelled Copper Wire		
	d.	Terminal	Tinned Copper Plate		
	e.	Adhesive	Ероху		

TAI-TECH P3

7. Reliability and Test Condition

Item	Perforn	nance		Test Condition
Operating Temperature	-40~+125℃			
Storage temperature	-40~+85°C (For products in unopened ta	pe package, less than 40°C	0)	
Rated Current	Base on temp. rise & △L/LOA=35% typ).		
Temperature Rise Test	40°C max. (∆t)			
Solder heat Resistance	Appearance: No significant abnormality. Inductance change: Within \pm 20%.	Preheating Dipping Natural co	5	Preheat:150°C,60sec. Solder : Sn-Ag3.0-Cu0.5 Solder tamperature:260±5°C Flux: rosin Dip time:10±0.5sec.
Solderability	More than 90% of the terminal electrode should be covered with solder.	Preheat:125±25°C,60sec. Solder: Sn-Ag3.0-Cu0.5 Solder tamperature:245±5°C Flux: rosin Dip time:4±1sec.		
Thermal shock	Appearance: no damage. Inductance: within±20%of initial value.	Phase Temperature(℃) 1 -25±2℃ 2 Room Temp. 3 +85±2℃ 4 Room Temp. Measured:50 times	Time(min) 30±3 15 30±3 15	For SDSL Condition for 1 cycle Step1:-25±2°C 30±3 min. Step2:Room temperature 15 min. Step3:+85±5°C 30±3 min. Step4: Room temperature 15 min. Number of cycles:50
Humidity Resistance Test	Appearance: no damage. Inductance: within±20%of initial value.	Temperature:40±2°C. Applied current:rated current. Duration:500 hrs. Humidity:90~95%		
High Temperature Resistance Test	Appearance: no damage. Inductance: within±20%of initial value.	Temperature:85±2℃. Applied current:rated current. Duration:500 hrs.		
Random Vibration Test	Appearance: Cracking, shipping and an characteristics should not be allowed. Inductance: within±20%of initial value.	y other defects harmful to t	the	Frequency: 10-55-10Hz for 1 min. Amplitude: 1.52mm Directions and times: X, Y, Z directions for 2 hours. A period of 2 hours in each of 3 mutually perpendicular directions (Total 6 hours).

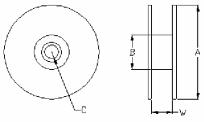
8. Recommended PC Board Pattern



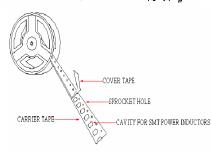
TAI-TECH P4

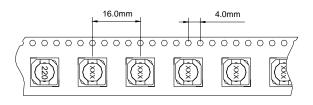
9. Packaging Information

9-1. Reel Dimension & Tape Dimension



Туре	A(mm)	B(mm)	C(mm)	W(mm)
13"x24mm	330	100	13±0.5	24.5

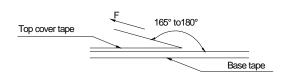




9-2. Packaging Quantity

SDSL	10D50F
Chip / Reel	750
Carton	4500
Reel Style	13"x24mm

9-3. Tearing Off Force



The force for tearing off cover tape is 10 to 130 grams in the arrow direction under the following conditions(referenced ANSI/EIA-481-C-2003 of 4.11 stadnard).

taariara).			
Room Temp.	Room Humidity	Room atm	Tearing Speed
(℃)	(%)	(hPa)	mm/min
5~35	45~85	860~1060	300

Application Notice

Storage Conditions

To maintain the solderability of terminal electrodes:

- 2. Recommended products should be used within 12 months form the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.



Test Report

號碼(No.): CE/2012/21594 日期(Date): 2012/02/20 頁數(Page): 1 of 8

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以下測試樣品係由客户送樣, 且由客户聲稱並經客户確認如下 (The following samples was/were submitted and identified by/on behalf of the client as):

樣品名稱(Sample Description)

: SSL · SPL · SSLM · SDSW · SDSL · SDSG SERIES

樣品型號(Style/Item No.)

: SSL \ SPL \ SSLM \ SDSW \ SDSL \ SDSG SERIES

收件日期(Sample Receiving Date)

: 2012/02/14

測試期間(Testing Period)

医碘异种蛋白蛋白 医二氏虫

: 2012/02/14 TO 2012/02/20

請見下一頁 (Please refer to next pages). 測試結果(Test Results)

∖®per£t/on Managei Chenyu Kung / Signed for and on behalfigh SGS TAIWAN LTD.

Chemical Laboratory - Taipei

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台灣檢驗科技股份有限公司

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/测試報告

Test Report

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測試結果(Test Results)

測試部位(PART NAME)No.1

整體混測 (MIXED ALL PARTS)

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鎬 / Cadmium (Cd)	mg/kg	 參考IEC 62321: 2008方法, 以感應耦合電	2	n.d.
鉛 / Lead (Pb)	mg/kg	地方工作的水柱体队则 / W: (1	2	n.d.
汞 / Mercury (Hg)	mg/kg	ICP-AES.	2	n.d.
六價鉻 / Hexavalent Chromium Cr(VI)	mg/kg	参考IEC 62321: 2008方法,以UV-VIS檢測. / With reference to IEC 62321: 2008 and performed by UV-VIS.	2	n.d.
鹵素 / Halogen				
鹵素(氟)/ Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg		50	n.d.
鹵素(氣)/ Halogen-Chlorine (Cl) (CAS No.: 22537-15-1)	mg/kg	参考BS EN 14582:2007, 以離子層析儀分析. / With reference to BS EN	50	n.d.
鹵素(溴)/ Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg	14582:2007. Analysis was performed by IC.	50	n.d.
鹵素 (碘) / Halogen-Iodine (I) (CAS No.: 14362-44-8)	mg/kg		50	n.d.

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Test Report

日期(Date): 2012/02/20 頁数(Page): 3 of 8 號碼(No.): CE/2012/21594

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CITY, TAO-YUAN HSIEN, TAIWAN, R. O. C.) (廣東省東莞市黄江鎮黄牛埔福祥街2號 / NO. 2, FUXIANG STREET, HUANGNIUPU, HUANGJIANG TOWN,

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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
多溴聯苯總和 / Sum of PBBs	mg/kg		-	n.d.
一溴聯苯 / Monobromobiphenyl	mg/kg		5	n.d.
二溴聯苯 / Dibromobiphenyl	mg/kg		5	n.d.
三溴聯苯 / Tribromobiphenyl	mg/kg		5	n.d.
四溴聯苯 / Tetrabromobiphenyl	mg/kg	ê.	5	n.d.
五溴聯苯 / Pentabromobiphenyl	mg/kg		5	n.d.
六溴聯苯 / Hexabromobiphenyl	mg/kg		5	n.d.
七溴聯苯 / Heptabromobiphenyl	mg/kg	参考IEC 62321: 2008方法, 以氣相層析儀/	5	n.d.
八溴聯苯 / Octabromobiphenyl	mg/kg		5	n.d.
九溴聯苯 / Nonabromobiphenyl	mg/kg		5	n.d.
十溴聯苯 / Decabromobiphenyl	mg/kg		5	n.d.
多溴聯苯醚總和 / Sum of PBDEs	mg/kg	質譜儀檢測. / With reference to IEC	_	n.d.
一溴聯苯醚 / Monobromodiphenyl ether	mg/kg	62321: 2008 and performed by GC/MS.	5	n.d.
二溴聯苯醚 / Dibromodiphenyl ether	mg/kg		5	n.d.
三溴聯苯醚 / Tribromodiphenyl ether	mg/kg		5	n.d.
四溴聯苯醚 / Tetrabromodiphenyl ether	mg/kg		5	n.d.
五溴聯苯醚 / Pentabromodiphenyl ether	mg/kg		5	n.d.
六溴聯苯醚 / Hexabromodiphenyl ether	mg/kg		5	n.d.
七溴聯苯醚 / Heptabromodiphenyl ether	mg/kg		5	n.d.
八溴聯苯醚 / Octabromodiphenyl ether	mg/kg		5	n.d.
九溴聯苯醚 / Nonabromodiphenyl ether	mg/kg		5	n.d.
十溴聯苯醚 / Decabromodiphenyl ether	mg/kg		5	n.d.

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備註(Note):

The Armag School and a section

- 1. mg/kg = ppm ; 0.1wt% = 1000ppm
- 2. n.d. = Not Detected (未檢出)
- 3. MDL = Method Detection Limit (方法偵測極限値)
- 4. "-" = Not Regulated (無規格值)
- 5. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個别單一材質的含量. (The samples was/were analyzed on behalf of the applicant as mixing sample in one testing. The above results was/were only given as the informality value.)

Wild Otto Co.

1-31 -0

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測試報告 Test Report

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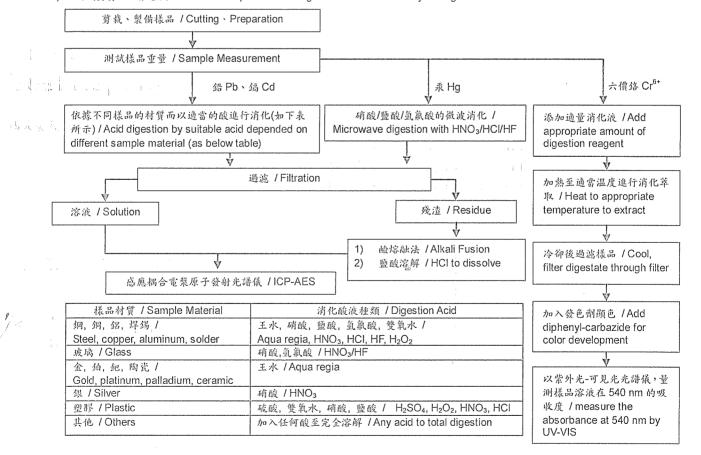
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- 1) 根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外) / These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr6+ test method excluded)
- 测試人員:楊登偉 / Name of the person who made measurement: Climbgreat Yang
- 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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沙测試報告

Test Report

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分析流程圖 / Analytical flow chart

- 測試人員: 翁賜彬 / Name of the person who made measurement: Roman Wong
- 测試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang

【測試項目(Test Items): 多溴聯苯/多溴聯苯醚、四溴雙酚-A-雙 / PBB/PBDE, TBBP-A-bis】 樣品 / Sample Washington of the 樣品前處理 / Sample pretreatment 初篩分析 / Screen analysis 医抗抗部品性现象 医性尿管 医皮肤 医皮肤 医皮肤 医皮肤 樣品萃取法 / Sample extraction method 萃取液濃縮/稀釋 / Concentrate/Dilute Extracted solution 萃取液過濾 / Filter 氣相層析質譜儀分析 / Analysis by GC/MS Issue Report / 撰打報告

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Test Report

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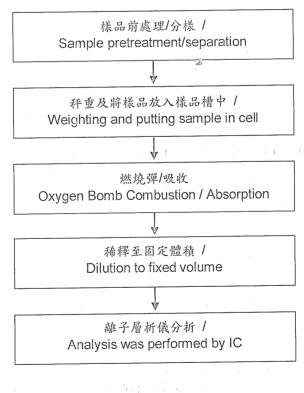
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鹵素分析流程圖 / Analytical flow chart of halogen content

- 1) 测試人員: 陳恩臻 / Name of the person who made measurement: Rita Chen
- 2) 测試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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測試報告 Test Report

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> * 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. * (The tested sample / part is marked by an arrow if it's shown on the photo.)

> > CE/2012/21594

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